

Notice of References Cited	Application/Control No. 10/701,258	Applicant(s)/Patent Under Reexamination LANG ET AL.	
	Examiner Jeffrey D. Lane	Art Unit 2828	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0012377	01-2002	Suganuma et al.	372/98
	B	US-H0,001,965 h	06-2001	Burns et al.	372/22
	C	US-2003/0214700	11-2003	Sidorin et al.	359/334
	D	US-6,432,471	08-2002	Cook, Christopher	427/10
	E	US-6,885,687	04-2005	Hayakawa, Toshiro	372/21
	F	US-6,600,563	07-2003	Bahatt et al.	356/445
	G	US-6,452,720	09-2002	Naganuma et al.	359/341.31
	H	US-6,829,278	12-2004	Allenson et al.	372/50.1
	I	US-6,704,509	03-2004	Yang et al.	398/34
	J	US-5,956,355	09-1999	Swanson et al.	372/20
	K	US-6,215,809	04-2001	Ziari et al.	372/96
	L	US-6,614,584	09-2003	Govorkov et al.	359/328
	M	US-6,816,516	11-2004	Daiber, Andrew	372/20

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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